#### ATENT COOPERATION TREA. 1

### From the INTERNATIONAL SEARCHING AUTHORITY

To: SEMICONDUCTOR ENERGY LABORATORY CO., LTD.
398. Hase. Atsugi -shi Kanagawa

### PCT

2430036 Japan

WRITTEN OPINION OF THE INTERNATIONAL SEARCHING AUTHORITY (PCT Rule 43 bis.1)

Date of mailing (day/month/year) 18.04.2006 Applicant's or agent's file reference. FOR FURTHER ACTION 00000PCT8457 See paragraph 2 below International application No. International filing date (day/month/year) Priority date (day/month/year) PCT/JP2005/024018 21.12.2005 24.12.2004 International Patent Classification (IPC) or both national classification and IPC Int.Cl. H01L21/027(2006.01), H01L21/20(2006.01), H01L21/336(2006.01), H01L29/786(2006.01) Applicant SEMICONDUCTOR ENERGY LABORATORY CO., LTD.

ı.	This	opinion contain	s indications relating to the following items:	
	V	Box No. I	Basis of the opinion	
		Box No. II	Priority	
		Box No. III	Non-establishment of opinion with regard to novelty, inventive step and industrial applicability	
		Box No. IV	Lack of unity of invention	
	V	Box No. V	Reasoned statement under Rule 43 bis.1(a)(i) with regard to novelty, inventive step or industrial applicability; citations and explanations supporting such statement	
		Box No. VI	Certain documents cited	
		Box No. VII	Certain defects in the international application	
		Box No. VIII	Certain observations on the international application	
2.	FURT	HER ACTION		
	If a demand for international preliminary examination is made, this opinion will be considered to be a written opinion of the International Preliminary Examining Authority ("IPEA") except that this does not apply where the applicant chooses an Authority other than this one to be the IPEA and the chosen IPEA has notified the International Bureau under Rule 66.1bis(b) that written opinions of this International Searching Authority will not be so considered.			
	If this opinion is, as provided above, considered to be a written opinion of the IPEA, the applicant is invited to submit to the IPEA a written reply together, where appropriate, with amendments, before the expiration of 3 months from the date of mailing of Form PCT/ISA/220 or before the expiration of 22 months from the priority date, whichever expires later.			
			e Form PCT/ISA/220.	
3.	For fu	ther details, see	notes to Form PCT/ISA/220.	

Date of completion of this opinion 05.04.200	6		
Name and mailing address of the ISA/JP	Authorized officer	2M	9355
Japan Patent Office	IWAMOTO, Tsutomu		
l <u> </u>	Telephone No. +81-3-3581-1101	Ext. 3274	

# WRITTEN OPINION OF THE INTERNATIONAL SEARCHING AUTHORITY

International application No.

PCT/JP2005/024018

Во	x No. I	Basis of the opinion
1.	With	regard to the language, this opinion has been established on the basis of:
	V	the international application in the language in which it was filed
		a translation of the international application into , which is the language of a
		translation furnished for the purposes of international search (Rules 12.3(a) and 23.1(b)).
2.	With claim	regard to any nucleotide and/or amino acid sequence disclosed in the international application and necessary to the ed invention, this opinion has been established on the basis of:
	a. typ	e of material
		a sequence listing
		table(s) related to the sequence listing
		mat of material
		on paper in electronic form
	L_j	in electronic form
	c. tim	e of filing/furnishing
		contained in the international application as filed
		filed together with the international application in electronic form
		furnished subsequently to this Authority for the purposes of search
3.		In addition, in the case that more than one version or copy of a sequence listing and/or table(s) relating thereto has been filed or furnished, the required statements that the information in the subsequent or additional copies is identical to that in the application as filed or does not go beyond the application as filed, as appropriate, were furnished.
4.	Additi	onal comments:
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# WRI LIEN OPINION OF THE INTERNATIONAL SEARCHING AUTHORITY

International application No.

PCT/JP2005/024018

Statement			
Novelty (N)	Claims	1-19	YES
	Claims		NO
Inventive step (IS)	Claims		YES
	Claims	1-19	NO
Industrial applicability (IA)	Claims	1-19	YES
	Claims		NO

2. Citations and explanations:

D1: JP 10-284418 A (SHARP KK) 1998.10.23

Claims 1-19

The subject matters of claims 1-19 do not appear to involve an inventive step in view of the document D1 cited in the ISR.

The D1 (See [0023]) discloses that mean crystal grain size differs depending on each region and generates a dimensional difference in surface unevenness of the polycrystalline silicon film.

The D1(See [ 0058]) discloses:

microscope 55 for observing the surface of the glass substrate 40 on the stage 51; a CCD (Charge-Coupled Device) camera 56 mounted on the microscope 55; and an image data processing section 57 which receives an image data signal from the CCD camera 56 and operates to process and store therein the image data.

And the D1 (See [ 0059] ) discloses that the surface of the polycrystalline silicon film 41 is observed by a dark-field method for observing the object to be observed by only the scattered light of the object.

Since, the D1 discloses detecting the plurality of regions with scattering intensities of reflected light depending on each crystal grain size of silicon film, the skilled person in the art would easily conceive the idea of present invention in view of the D1 and well-known art.